Electronic Supplementary Material (ESI) for Journal of Materials Chemistry A. This journal is © The Royal Society of Chemistry 2020

Synthesis and Electrochemical Properties of 2D Molybdenum Vanadium Carbides – Solid Solution MXenes

David Pinto^{a,b}, Babak Anasori^{a,b}, Hemesh Avireddy^{a,b,c}, Christopher E. Shuck^{a,b}, Kanit Hantanasirisakul^{a,b}, Grayson Deysher^{a,b}, Joan Ramon Morante^{c,d}, William Porzio^e, Husam N. Alshareef^f, Yury Gogotsi^{a,b}

^a Department of Materials Science & Engineering, Drexel University, Philadelphia, PA 19104, USA.

^b A.J. Drexel Nanomaterials Institute, Drexel University, Philadelphia, PA 19104, USA

^c IREC, Catalonia Institute for Energy Research, Jardins de les Dones de Negre 1, 08930. Sant Adrià de Besòs, Spain ^d Faculty of Physics, University of Barcelona, Barcelona, Spain

^e Institute of Chemical Sciences and Technologies "G.Natta" Consiglio Nazionale delle Ricerche (SCI-TEC) via A. Corti 12 20133, Milano, Italy

^f Materials Science and Engineering, King Abdullah University of Science and Technology (KAUST), Thuwal, 23955-6900, Saudi Arabia

SUPPORTING INFORMATION

Synthesis protocol of Ti₃C₂ MXene films. Ti₃C₂ films were produced by MILD synthesis and vacuum-assisted filtration, as described elsewhere.¹ Briefly, 0.5 g of Ti₃AlC₂ MAX (Carbon-Ukraine) was gradually added (over 30 s) to a stirred etchant solution composed of 10 mL 9 M HCl (Acros Chemicals) and 0.8 g of LiF (Sigma-Aldrich). The mixture was stirred at room temperature for 24 h in a plastic 25 mL container with a loose cap. After etching, the mixture was washed by centrifugation (5 min, 3500 rpm) until the observation of the sediment swelling (pH close to 5). At this step, the centrifugation time is increased to 1 h and the MXene is washed until neutral pH. Finally, the sediment is redispersed and centrifuged at 3500 rpm for 3 min. The supernatant is collected and filtered as a film by vacuum-assisted filtration.



Figure S1. X-ray diffraction (XRD) pattern of high-molybdenum content $Mo_xV_{4-x}AlC_3$ composition, for x = 3.5, compared to the expected pattern for $Mo_xV_{4-x}AlC_3$ MAX (hexagonal P6₃/mmc structure). The XRD pattern of $Mo_{3.5}V_{0.5}AlC_3$ composition diverges from the expected $Mo_xV_{4-x}AlC_3$ P6₃/mmc pattern. Most peaks from the expected pattern are absent or significantly shifted and unexpected peaks indicate secondary products and/or unattended structures.



Figure S2. X-Ray diffraction (XRD) patterns of loose MAX powders for Rietveld refinement (RR) and purity determination on GSAS-II code. **a.** Conventional XRD patterns recorded on Rigaku Smartlab (from top to bottom: $Mo_{2.7}V_{1.3}AlC_3$, $Mo_2V_2AlC_3$, $Mo_{1,5}V_{2,5}AlC_3$, and MoV_3AlC_3 ; RR phase peaking for $Mo_{2.7}V_{1.3}AlC_3$, similar for other phases). Experimental data are the dark line, calculated data are the red line, the background is printed in blue and the difference in grey. Impurities, secondary products and purity level are depicted in Table S1 (Supporting Information). **b.** Complementary synchrotron measurements acquired at a wavelength $\lambda = 0.7$ nm (from top to bottom: $Mo_2V_2AlC_3$, $Mo_2V_2AlC_3$, $Mo_2V_2AlC_3$), and **c.** synchrotron data reported for a

$$\theta_{K\alpha} = \arcsin\left(\frac{E_{\lambda}\sin\left(\frac{\theta_{\lambda}}{2}\right)}{E_{K\alpha}}\right), \text{ with } E_{K\alpha} = 0.8051 \text{ keV and } E_{\lambda} = 0.8051 \text{ keV}$$

conventional Cu K α radiation (λ = 1.54 nm), through equation

1.77 keV. From top to bottom: Mo₂V₂AlC₃, Mo_{2.7}V_{1.3}AlC₃ and the calculated pattern of Mo₂V₂AlC₃.

Table S1. Evaluation of impurities, secondary phases and Mo_xV_{4-x}AlC₃ purity level by Rietveld refinement (GSAS-II code, figure

S1, Supporting Information)

	Intermetallic (at. %)				Carbide (at. %)			
	Al₅Mo	Al₃Mo	AI_2Mo_3	MoV	VC	V ₂ AIC	Mo ₂ C	Mo _x V _{4-x} AlC ₃
Mo _{2.7} V _{1.3} AIC ₃	3.10	0	3.2	0	0	0	18.42	75.28
Mo ₂ V ₂ AlC ₃	6.30	1.3	0	0	3.20	0	0	89.20
Mo _{1.5} V _{2.5} AIC ₃	2.74	0.29	0	0.20	0	5.19	0	91.58
MoV ₃ AlC ₃	0	4.26	0	0	0.19	0.19	0.19	95.17



Figure S3. Scanning electron microscopy images of layered $Mo_xV_{4-x}AlC_3$ MAX particles: **a.** $Mo_{2.7}V_{1.3}AlC_3$, **b.** $Mo_2V_2AlC_3$, **c.** $Mo_{1.5}V_{2.5}AlC_3$, **d.** MoV_3AlC_3 .



Figure S4. Characterization of multilayer powders after etching in 50% hydrofluoric acid for 96 h at 50 °C. **a.** X-ray diffraction of multilayer MXene powders (from top to bottom: $Mo_{2.7}V_{1.3}C_3$, $Mo_2V_2C_3$, $Mo_{1.5}V_{2.5}C_3$, MoV_3C_3). **b.** Evidence of the (002) peak shift (black arrow) to the highest 2^{θ} from $Mo_{2.7}V_{1.3}C_3$ to MoV_3C_3 multilayers. Scanning electron microscopy images of multilayers MXene: **c.** $Mo_{2.7}V_{1.3}C_3$, **d.** $Mo_2V_2C_3$, **e.** $Mo_{1.5}V_{2.5}C_3$ and **f.** MoV_3C_3 all showing an accordion-like morphology.



Figure S5. Chemical characterization of $Mo_xV_{4-x}AlC_3$ MAX powders and $Mo_xV_{4-x}C_3$ multilayer MXene produced after etching MAX in 50% hydrofluoric acid at 50 °C for 96 h. **a.** Aluminum content, x(Al) (moles), in the MAX and MXene after etching and, yield of delamination, $\eta = x(Al)_{MXene}/x(Al)_{MAX}$ (%) as a function of the composition x(Mo)_{Th} (moles). **b.** Evaluation of the oxygen and fluorine content (moles) of the MXene MLs as a function of the composition x(Mo)_{Th} (moles). x(Al), x(O) and x(F) are determined by energy dispersive X-ray spectroscopy, focusing on a multilayer MXene and neglecting other particles to exclude any effect of eventual impurities on the results and, the values and errors result from at least 4 measurements on different particles. x(Mo)_{Th} (moles) reflects the expected Mo content in the MXene multilayer (*and MAX*) powders: x(Mo)_{Th} = 1, MoV₃(*Al*)/C₃; x(Mo)_{Th} = 1.5, Mo_{1.5}V_{2.5}(*Al*)/C₃; x(Mo)_{Th} = 2, Mo₂V₂(*Al*)/C₃; x(Mo)_{Th} = 2.7, Mo_{2.7}V_{1.3}(*Al*)/C₃.



Figure S6. Cyclic voltammetry on films of (from the highest to the lowest gravimetric capacitance, C_G) $Mo_{2.7}V_{1.3}C_3$, $Mo_2V_2C_3$, MoV_3C_3 , at 10 mV s⁻¹. Etching conditions: 96 h, 50% hydrofluoric acid, 50 °C.



Figure S7. Nyquist plots at 10 mV on $Mo_{2.7}V_{1.3}C_3$ films in various **a.** non-acidified electrolytes pH ~7 and **b.** acidified electrolytes 2.19 < pH < 2.36 (with H₂SO₄) in half cells.



Figure S8. Cyclic voltammograms recorded at scan rates of 5, 10, 20, 50 and 100 mV s⁻¹ for acidified a. Li₂SO₄, b. Na₂SO₄, c. MgSO₄, d. K₂SO₄ electrolytes with H₂SO₄ (2.19 \leq pH \leq Li₂SO₄, Na₂SO₄, 2.36), non-acidified f. MgSO₄, h. K_2SO_4 electrolytes and, acidic H_2SO_4 electrolytes e. g. i. 1 Μ



Figure S9. Phase angle at 10 mHz for various applied potential within the electrochemical window (every 100 mV) of MXene in **a.** acidified ($2.19 \le pH \le 2.36$) and **b.** non-acidified electrolytes depicting capacitive (90°) to diffusion controlled (45°) activity of Mo_{2.7}V_{1.3}C₃ in 1 M Li₂SO₄, 1 M Na₂SO₄, 0.5 M K₂SO₄, 1 M MgSO₄.



Figure S10. Impedance spectroscopy analysis of Mo_{2.7}V_{1.3}C₃ MXene in various non-acidified electrolytes (1 M Li₂SO₄, 1 M Na₂SO₄, 1 M MgSO₄, 1 M K₂SO₄) for potential ranging from 0.2 V vs. Ag/AgCl to -0.8 V vs. Ag/AgCl. **a-d.** Nyquist in **a.** Li₂SO₄, **b.** Na₂SO₄, **c.** MgSO₄ and **d.** K₂SO₄. **e-h.** Corresponding cyclic voltammograms at 5 mV s⁻¹ for **e.** Li₂SO₄, **f.** Na₂SO₄, **g.** MgSO₄ and **h.** K₂SO₄.



Figure S11. Impedance spectroscopy analysis of Mo_{2.7}V_{1.3}C₃ MXene in various acidified electrolytes (1 M Li₂SO₄ pH 2.3, 1 M Na₂SO₄ pH 2.32, 1 M MgSO₄ pH 2.19, 1 M K₂SO₄ pH 2.36) for potentials ranging from 0.4 V vs. Ag/AgCl to -0.5 V vs. Ag/AgCl **a-d.** Nyquist in **a.** Li₂SO₄ pH 2.3, **b.** Na₂SO₄ pH 2.32, **c.** MgSO₄ pH 2.19 and **d.** K₂SO₄ pH 2.36. **e-h.** Corresponding cyclic voltammograms at 5 mV s⁻¹ for **e.** Li₂SO₄ pH 2.3, **f.** Na₂SO₄ pH 2.32, **g.** MgSO₄ pH 2.19 and **h.** K₂SO₄ pH 2.36



Figure S12. Characterization of Ti₃C₂ electrode within the condition of the asymmetric all-MXene supercapacitor. Cyclic voltammetry of Ti₃C₂ in **a.** H₂SO₄ 1 M, **b.** 1 M Na₂SO₄ pH 2.32, **c.** non-acidified 1 M Na₂SO₄, and **d.** gravimetric capacity from 5 100 mV s⁻¹.

to



Figure S13. Fitting of experimental data from impedance spectroscopy analysis of all-MXene supercapacitor in **a.** 1 M Na₂SO₄ pH 5.9, **b.** 1 M Na₂SO₄ pH 2.32, **c.** 1 M H₂SO₄ pH ca. 0 (lines are fits and circles are experimental data). **d.** Equivalent electrical circuit.

The equivalent electrical circuit employed for fitting is modified from the literature.^{2,3} The impedance response is characteristic of a pseudocapacitor system.^{4,5} R₁ is the electrode series resistance (ESR), which mainly reflects the quality of the contact between the active material and the collector, as well as the overall resistance of this contact. Fitted Nyquist plots show that the double layer capacitance can be substituted by a CPE in order to fit the non-ideal high frequency semicircle (depressed aspect of semi-circle). Finally, R₂ stands for the charge transfer resistance and M represent the restricted linear diffusion across the electrode-electrolyte interface. ESR of each system evolves from 0.3 to 2 Ω cm² which accounts for а good collector to MXene contact with low resistance.

- 1. M. Alhabeb, K. Maleski, B. Anasori, P. Lelyukh, L. Clark, S. Sin and Y. Gogotsi, Chem. Mater., 2017, 29, 11.
- 2. H. Gao, X. Wang, G. Wang, C. Hao, S. Zhoua and C. Huang, Nanoscale, 2018, 10, 10190-10202.
- 3. H. Gao, X. Wang, G. Wang, C. Hao, C. Huang and C. Jiang, J. Mater. Chem. C, 2019, 7, 13267-13278
- 4. Q. Jiang, N. Kurra, M. Alhabeb, Y. Gogotsi, H.N. Alshareef, Adv. Energy Mater., 2018, 8, 1703043.

5. H. Avireddy, B.W. Byles, D. Pinto, J.M.D. Galindo, J.J. Biendicho, X. Wang, C. Flox, O. Crosnier, T. Brousse, E. Pomerantseva, J.R. Morante,

Y. Gogotsi, Nano Energy, 2019, **64**, 103961.